Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/796,519	CHIANG, KAN CHUN	IANG, KAN CHUN	
Examiner	Art Unit	Unit	
Alan S. Chen	2182	2	

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Clas	is	Subclass		Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT Inventor Search	10/16/2006	ASC
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